

Notice of References Cited	Application/Control No. 10/556,720		Applicant(s)/Patent Under Reexamination WATANABE ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP 648788 A1	04-1995	European Patent	SATOH et al.	-----
*	O	GB 2125420 A	03-1984	United Kingdom	LENNEY W E	-----
*	P	JP 11335491 A	12-1999	Japan	NAGASAWA et al.	-----
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Translation to Yashima et al. (JP 2002053703) (2002)
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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